

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/683,732	PELHAM ET AL.
	Examiner	Art Unit
	Junghwa M. Im	2811

ISSUE CLASSIFICATION									
ORIGINAL		CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
257	371	257	369	372	373	210	206	403	374
INTERNATIONAL CLASSIFICATION		257	355	299	544	216	349	536	401
H	0	1	L	29/76	257	296			
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Junghwa Im 3-1-2006 (Assistant Examiner) (Date) <i>Upalanda Polina</i> 3/20/06 (Legal Instruments Examiner) (Date)				EDDIE LEE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) <i>Allen</i> 3/2/06 (Date)				Total Claims Allowed: 56	
								O.G. Print Claim(s) 1	O.G. Print Fig. 5B

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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5	5	35	35	65	95	125	155
6	6	36	36	66	96	126	156
7	7	37	37	67	97	127	157
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9	9	39	39	69	99	129	159
10	10	40	40	70	100	130	160
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12	12	42	42	72	102	132	162
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